SCIENCE CITY RESEARCH ALLIANCE

UNIVERSITY OF THE UNIVERSITY OF BIRMINGHAM WARWICK

Facilities & equipment

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Introduction

The Science City Research Alliance (SCRA) brings together the West Midlands' two leading research led universities, the University of Birmingham and the University of Warwick, in collaborative projects across scientific themes in Advanced Materials, Energy and Translational Medicine as part of the Birmingham Science City* initiative.

The Advanced Materials programme consists of two projects:

AM1: Creating and Characterising Next Generation of Advanced Materials

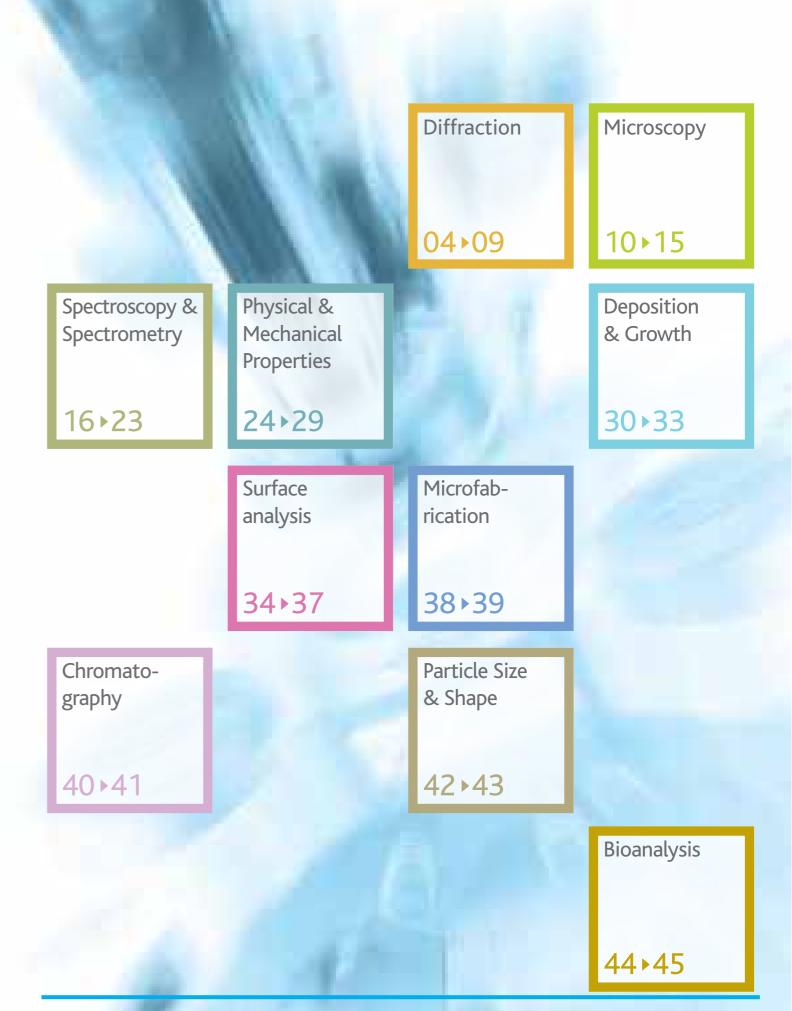
AM2: Innovative Uses of Advanced Materials in the Modern World

Both projects are funded by Advantage West Midlands (AWM) and the European Regional Development Fund (ERDF) which have enabled the projects to invest over £17M in scientific equipment functional disciplines to help categorise across Physics, Chemistry, Chemical Engineering, Metallurgy & Materials and available. In each section equipment Dentistry departments at both institutional items have short descriptions plus campuses. This investment has created a 'features' box to highlight specifics world leading state-of-art research facilities for the region that are accessible not only to the Universities of Warwick and Birmingham but also to other HEIs and private businesses.

The projects have invested in the equipment to further enhance and develop research in areas such of nanotechnology, coating and surfaces, multifunctional materials, biomaterials, fracture and fatigue analysis. However the application of the equipment is not restricted only to these areas so please speak to project staff regarding vour interests

This booklet is structured into 10 broad the vast array of instrumentation of that particular instrument. The descriptions are brief and are intended to provide an overview of the capabilities only. Under each equipment item details of the university location is provided in the grey box. As equipment across these projects vary from bespoke instruments to off the shelf analysis machines, it is strongly encouraged that you talk with the projects' Business Engagement Managers who can guide provide further equipment information and assist in suggesting the best match of facilities and expertise to individual research or measurement requirements.

Equipment access and usage is charged at University FEC rates providing a very cost effective option to businesses. Collaborative research projects, contract research work and analytical services to provide data generation and interpretation are all possible through the AM projects. Project Business Engagement Managers should be approached to gain further information on types of services and the access options available.



* Birmingham Science City is a region-wide partnership of public sector, businesses and the research base, which is facilitating the use of science and technology to improve the quality of life and prosperity of the West Midlands. Funded by Advantage West Midlands, Birmingham Science City's aim is to create strategies to exploit centres of world-class scientific research, by developing relevant activities for sustainable economic and social benefit.

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CONTENTS // ADVANCED MATERIALS

Bruker D8 Advance Diffractometer



Location: Birmingham 1.1 & 1.2

Bruker D5000 & D5005 Diffractometer

D5000

Routine measurement of powder X-ray diffraction patterns of samples in capillaries from 80 to 500K. This system will be of most interest to those looking at organic samples such as pharmaceuticals or air-sensitive species.

Features

High resolution powder X-ray Diffractometer operating in capillary mode with low emperature cryostream, monochromatic Cu radiation, Braun position-sensitive detector.

Location: Birmingham 1.3 & 1.4

04.08 Diffaction

ADVANCED MATERIALS // DIFFRACTION

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Routine measurement of powder X-ray diffraction patterns for identification of crystalline phases, purity estimation and/or determination of crystal structure, measurement of powder X-ray diffraction patterns up to 1100°C in air.

Features

High resolution powder X-ray Diffractometer operating in transmission mode with automatic sample changer, monochromatic Cu radiation, LynxEye position-sensitive detector.

D5005

Routine measurement of medium resolution powder X-ray diffraction patterns using Cu or Mo radiation.

Features

Powder X-ray Diffractometer operating in reflection mode using Cu or Mo radiation.

Bruker S8 Tiger X-Ray Fluorescence (XRF) Spectrometer



This system is capable of determining the elemental composition of samples, including solids, powders and liquids. It is able to detect elements from oxygen through to uranium.

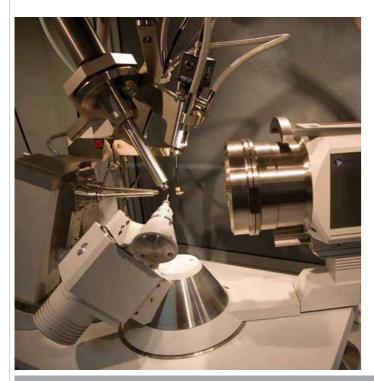
The system is not optimised for elements lighter than oxygen and therefore not suitable for purely hydrocarbons or organics. Sample sizes can range from powders below 1g, to solids with diameters of up to 3cm (flat surface required). The measurement is non-destructive in most cases.

Features

- Wavelength Dispersive XRF system
- Elemental analysis of materials, predominately inorganic solids and powders
- Optimised for detecting and quantifying elemental components ranging from oxygen through to uranium at major, minor and trace (ppm) levels
- Capable of handling small sample sizes (<1g)
- Qualitative, fully quantitative and standardless analyses.

Location: Birmingham 1.9

Oxford Diffraction Gemini R CCD Diffractometer



Location: Warwick 1.30

X-ray diffraction is an important tool for structural determination of single crystals, both organic and inorganic. Usage spans from routine structural work on organic and metal-organic small molecules to highly detailed investigations of heavy metal oxides that can include twins, modulated structures or diffuse scattering.

Features

The Oxford Diffraction Gemini R CCD X-ray Diffractometer is a powerful tool for the neasurement of single crystals. The Gemini R is a Kappa geometry goniometer equipped with dual wavelength (Cu/Mo) fine focus X-ray sources, graphite monochromators and Enhance optics. The detector is a Ruby Charge Coupled Device area detector, which allows for extremely fast data collection of the entire Ewald sphere. The Oxford Diffraction CrysAlisPro software enables data collection, data integration and absorption corrections to be performed, and is used in conjunction with refinement software such as ShelX or Jana. For low temperature experiments (80K-400K) an Oxford Cryosystems Cobra is attached to the system. Additionally, an optical stereomicroscope is used for nounting and alignment of samples.

Panalytical X'Pert Pro MRD



Location: Warwick 1.28

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High resolution X-ray diffraction is an important technique for studying individual Bragg peaks of single-crystal and thin-film materials.

This machine is suitable for the study of single crystals, thin films (including multilayers) and polycrystalline materials (e.g. ceramics). Typical materials include semiconductors (SiGe, GaAs etc), Magnetic Multilayers, Ferroelectrics (PZT, LiNbO3), Photovoltaic thin films and metallic rods / sheets.

Techniques available include:

- Rocking curve analysis and reciprocal space mapping Crystalline quality, accurate lattice parameters, strain & misorientation.
- Reflectometry and thin film phase analysis Layer thickness & composition
- Residual stress and texture analysis
- Diffuse scatter measurements
- In-plane and grazing incidence diffraction
- Non-ambient diffraction phase transitions, layer annealing studies.

Features

The Panalytical X'Pert Pro MRD is a high resolution single crystal X-ray Diffractometer. In its standard configuration, the MRD is equipped with a Cu K α 1 hybrid monochromator as the incident beam optics and a receiving slit / analyser crystal as the diffracted beam optics. This offers the best combination of counts to resolution for most routine applications.

The optics can be interchanged relatively quickly to tailor the Diffractometer to the application required. For highest resolution measurements, a mirror & monochromator combination can be used. For reflectivity measurements, a parallel plate collimator is available on the diffracted beam optics enabling measurements out to larger angles than possible with the standard optics.

Additionally, the optics can also be reequipped to allow stress and texture measurements to be undertaken in point focus. The MRD is equipped with a PiXcel solid state detector enabling better counting statistics, high linearity and eliminating the need for a beam attenuator. An Anton Paar DHS900 domed hot stage, allowing non-ambient studies on thin-films and ceramics at temperatures of up to 900°C. Software is available for the analysis of rocking curves, reflectivity, stress and texture measurements.

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Bruker D8 Advance Powder X-Ray Diffractometer



Location: Warwick 1.29

X-ray powder diffraction is a powerful technique for phase identification and structural determination.

Applications of this environmental Diffractometer include:

- Catalysts under real reactive conditions Oxidising or reducing gases
- Kinetic studies of solid state reactions Thermal decompositions, gas solid reactions, phase changes
- Solid gas reactions at elevated pressure (10 bar) and temperature (900°C)
- Structural changes under redox reaction conditions
- High temperature material stability with fast data collection phase separation and collapse
- Gas uptake by porous materials H, CO₂.

Features

The Bruker D8 Advance Powder X-ray Diffractometer is optimised for high-throughput in-situ gas reaction measurements. For maximum intensity and throughput, the Bruker D8 is equipped with unmonochromated Cu radiation and a Ni filtered VÅNTEC-1 solid state detector with a maximum active length of 12° 20. This allows very quick static (~10s) measurements to be made, particularly useful for kinetic studies. The sample is held in an Anton Paar XRK 900 reaction chamber, a chemical reaction cell for studies in the presence of reactive gases (oxidising and reducing) at up to 10 bar.

Software available includes Bruker EVA for data analysis and Topas for structural refinement. The latest ICCD powder diffraction database is also available which includes over 100K patterns.



DIFFRACTION // ADVANCED MATERIALS

ADVANCED MATERIALS // MICROSCOPY

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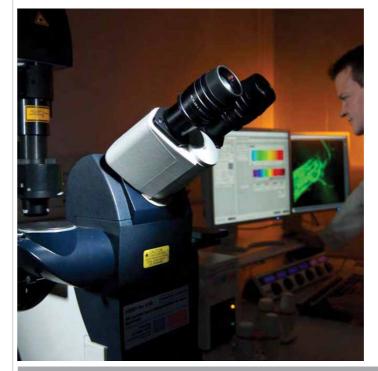
Raman Microscope

Renishaw InVia Reflex and Witec Alpha 300R



Location: Warwick & Birmingham 2.5a, 1.5 & 2E20

Confocal Microscope Leica TCS SP5 X & Leica TCS SPE



Location: Warwick & Birmingham 2.6a & 2E33

Provides spatially resolved information on structure, bonding, constituents, and electronic structure of a wide variety of functional and structural materials.

Examples of applications of Raman microscopy include the differentiation of polymorphs, chemical mapping in the pharmaceutical industry, detection and monitoring of stress in silicon based microelectronics, and identification of high temperature and pressure treated diamonds.

Features

- 325, 442, 514.5, 532, 633, 785nm lasers
- CCD detector for visible to near-IR plus InGaAs for IR
- Temperature: 77K 873K
- Automatic sample stage
- Surface mapping 1µm spatial resolution
- 3D analysis of transport samples using confocal option.

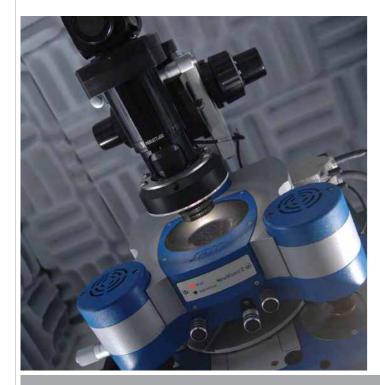
Confocal microscopy may be used to investigate soft matter surfaces and interfaces allowing observation of the interaction of a wide range of molecules including polymers, colloids, electrode (sensor) surfaces etc.

Allows ultra-fast imaging and the widest range of excitation wavelengths in the visible range via a continuously tuneable laser.

- Tuneable super continuum laser source: 470 to 670nm in 1nm increments
- Laser argon source with 5 selectable wavelengths from 458 to 514nm, diode laser 405nm
- Up to 8 simultaneous excitation wavelengths
- 5 detection channels
- Configurable in upright and inverted configurations
- Ultra fast bidirectional scan (max 16KHz).

Atomic Force Microscope (AFM)

NanoWizard & Veeco diMultimode V



Atomic force microscope capable of imaging in air and fluid as well as making electrical measurements. Large scale samples may be studied such as nanopartilces, electrode surfaces, thin films and biological samples.

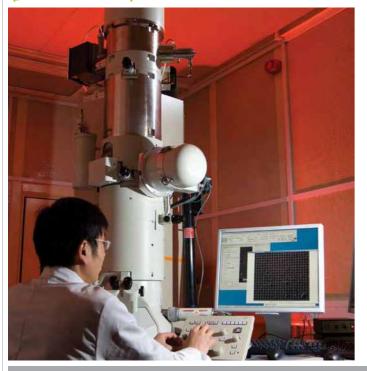
Measurements at variable temperatures with perfusion possibilities. Applications include 3D surface topography and adhesion force mapping.

eatures

- Large scan field of 100 \times 100 \times 15 μ m³
- Range (x, y, z): 100µm, 100µm, 100µm
- Sub Ångstrom resolution
- Dedicated conducting module
- Comprehensive range of accessories:
- Cellhesion controller
- Biocell controller
- Petri-dish Heater Electrochemical cell
- Biopotentiostat

Location: Warwick & Birmingham 2E29 & 2.8

JEOL Aberration-corrected Transmission Electron Microscope (JEM-2100F)



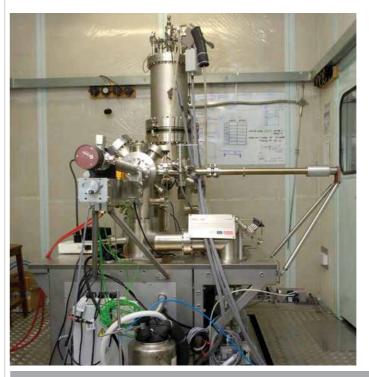
Location: Birmingham 1.2

High resolution imaging, Materials qualification, Chemical analysis, Particles detection/characterisation, Defects analysis, Microstructural characterisation.

Features

The JEM-2100F is a JEOL field emission gun transmission electron microscope with an:

- Ultra-high-resolution pole piece
- Operates at 200kV
- It can work in TEM mode with a point resolution of 0.19 angstrom and STEM mode with a corrected probe size of 1 angstrom.
- EELS energy resolution can get to 0.95 eV for standard beam emission.



Location: Birmingham 1.13

Ultra High Vacuum Scanning Tunnelling Microscope

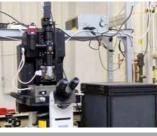


Atomic force microscope capable of imaging in air and fluid, as well as making electrical measurements. A wide range of samples may be studied such as nanoparticles, electrode surfaces, thin films and biological samples. Samples can be prepared in-situ by noble gas ion sputtering and annealing and direct heating (i.e. for semiconductor wafers). Gas, organic and electron beam metal molecular beam epitaxy (MBE) sources are available. STM can be used for structure determination of surfaces with molecular and

Location: Warwick 2.2

White Light Laser Source and Near Field Optical Microscope

Park high resolution AFM, Park Near Field Optical Microscope (NSOM), SC400 Fianium white laser source, Hammamatsu PMT, Andor CCD spectrometer, Tsunami laser.



The AFM permits to achieve morphological analysis of the samples with a resolution less than 1Å. Confocal system permits to achieve 3D optical images of the samples and to analyse their fluorescence properties. White laser source provide broadband excitation of the samples.

Location: Birmingham 1.16

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The key to STM is that it can image and probe individual atoms. This allows electronic and vibrational spectroscopy with atomic-scale spatial resolution. They can also image larger areas of surfaces (~ 2 mm²) still with high spatial resolution.

Possible applications range from probing the fundamentals of surface induced catalysis to arranging individual atoms in pre-designed structures, e.g., writing words and letters using individual atoms.

-eatures

- Operational temperature range: from 4.6K to 300K (measured with Si-diode) Conducting sample: metal, graphite and semiconductor
- Sample size: 10mm x10mm (standard sample plates)
- Scan range: 1.8x1.8µm² @4.6K 5.6x5.6µm² @ 300K
- Gap voltage: ± 1 V and ± 10 V (smallest increment 30µV and 300µV)
- Tunnelling current: 1pA to 300nA with feedback loop active
- Z-stability: <0.05 Å (rms)
- Temperature range of manipulator: up to 1170K on heater stage; down to < 100K on cooling stage
- Base pressure in ultra-high vacuum: 10-12~10-10 mbar
- Measurement control software: NANONIS SPM Control System.

- atomic resolution and local electronic structure determination.

Features

- Base pressure 1 x 10¹⁰ mbar
- Measurement temperatures liquid N₂ and liquid He including cooled sample manipulator
- Maximum scan area 400nm^a

- SC400 from Fiannium: 2W femtosecond white-light laser source (80MHz repetition rate. 400fs pulses, available wavelengths: 400-1500nm)
- XE-NSOM from Park Systems: Cantilever-base near-field optical scanning microscope both ir transmission & reflection modes (can be used a well as a contact, tapping or non-contact AFM)
- Nikon NE-2000 inverted microscope, used in conjunction with the NSOM for transmission mode
- Andor water-cooled CCD spect

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Zeiss Axioimager and Stemi2000 stereo microscopes

Optical Microscopy



Axio Imager from Carl Zeiss, designed for quality control, quality assurance, materials analysis, and for the development of new materials. Ideal for routine applications and research. Darkfield illumination reveals unevenesses in the surface (such as phase boundaries between graphite and matrix or break-outs). C-DIC (color contrast): The matrix is contrasted because of the relief. Hard and soft grain components as well as polishing inconsistencies (exclusively mechanically polished) are visible.

- Features
- Microscope can offer: 50 - 1000 times magnification Reflective/Transmitted light source Bright field imaging Dark field imaging Differential Interference Contrast imaging 3.2 megapixel carnera.

Location: Warwick 1.32

GATAN PIPS[™] Ion miller



For the thinning of samples such as silicon, ceramics, glass ceramics etc for viewing in the Transmission Electron Microscope.

Features

Features

electron microscopy

Wavelength range 185 - 850nm.

The PIPS is a user-friendly precision ion polisher designed to produce high quality, TEM specimens vith minimal effort. The muiller has a Liquid Nitroge cooled specimen stage and CCD zoom camera to view milling progress.

Spectra can be measured in parallel with scanning

Monochromatic and panchromatic imaging mode

Location:

Cathodoluminescence System

Gatan MonoCL3 with Digiscan

The Cathodoluminescence system is attached to a scanning electron microscope (SEM) and may be used to investigate chemical composition including trace elements, electronic structure, and studying stress information in semiconductors and insulators. The system may also be used for mineral analysis.

Location: Warwick 2.5b

High Speed Camera with Microscope	Features		
Leica DM 2500M with Vision Research Phantom Monochrome v.7.3	Up to 6688 frames per second at		
High speed camera system may be used to study microscale dynamic processes.	800 x 600 resolution 8, 10, 12 or 14 bit image depth		
	Continuously adjustable shutter speeds down to 1 µs.		
Location: Warwick 2.6b			

GATAN ORIUS® CCD

GATAN ORIUS® CCD camera - large format (11 Megapixel) retractable and fiber-optical coupled CCD

Viewing and recording images and electron diffraction patterns. The high speed viewing mode also allows the user to replace the traditional TEM viewing screen. Operations such as microscope alignments, stigmation, and focus can be performed with high precision using the camera display instead of the TEM viewing screen.

Location: Warwick 1.31

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The SC1000 offers a high speed (>14 fps - frames per second) image viewing mode. This allows the user to

search areas within the sample quickly and efficient

The SC1000 can output high quality (dark and gain orrected) LIVE images via a digital video stream

Another benefit of the high frame rate of the SC1000 s the capability of TEM in-situ observations



MICROSCOPY // ADVANCED MATERIALS

ADVANCED MATERIALS // SPECTROSCOPY & SPECTROMETRY

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Scanning Probe Energy Loss Spectrometer (SPELS) Instrument Development



Location: Birmingham 1.1

High Resolution Hybrid Mass Spectrometer Coupled with UHPLC

Bruker MaXis with Proxeon Easy-nLC and Dionex RS3000 HPLC & Bruker HCT-Ultra, ETD Discovery with Agilent 1200 UHPLC



Location: Warwick 2.4

This laboratory facility focuses on the design and development of new analytical instrumentation and techniques.

A present example being the SPELS; an instrument patented by the University of Birmingham (UK patent No. 0002367.1). A previous example of an instrument developed is the novel "time-of-flight" mass filter that is used to separate small particles of different sizes generated from a material source (metal or semiconductor). The mass filter is also patented in the UK and internationally.

Our extensive experience with instrumentation development allows us to provide services and consultancy.

-eatures

- Sample Size: 10mm x 10mm x 1mm
- Maximum scan range: 3um x 3um x 1.5um (height)
- Primary Beam energy range: 0-250 eV
- Energy resolution: 300meV
- Spatial resolution: sub um
- Room temperature only; Conducting samples only; Ultra high vacuum only; Surface sensitive

- Ultra high resolution time of flight mass spectrometer (TOF-MS) for use in applications such as: identification of small molecules, metabolomics quantitative proteomics, biomarker discovery,
- characterisation of (bio)polymers and supramolecular assemblies.

Features
lon trap MS:
CID/ETD
MS ⁿ
LC-MS/MS ⁿ
MaXis MS:
Resolution > 40,000 FWHM
MS and MS/MS mass accuracy typically between 600 - 800 ppb
Acquisition rate up to 20Hz

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Mass Spectrometry System for Surface Analysis

KORE Surface Seer



Time-of-flight secondary ion mass spectrometer (TOF-SIMS) instrument for characterisation of surfaces, detection of all elements as well as identification of organic species and thin film profiling.

Examples of use include the study of self-assembled monolayers.

Features

Positive and negative SIMS with reflectron analyser Mass range >1000m/z.

Location: Birmingham 2E5

MALDI Mass Spectrometer

Waters Micro MX



High-performance, matrix-assisted laser desorption/ionisation time-of-flight mass spectrometer featuring parallel position sensitive detection (PSD) technology for confirming protein identification and determining posttranslational modifications.

Negative ion capability allows applications in genotyping and polysaccharide analysis.

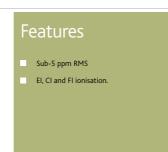
Location: Birmingham 2E

Gas Chromotagraphy Mass Spectrometer (GCMS)

Waters GCT Premier



An orthogonal acceleration time-of-flight mass spectrometer with high resolution for the selectivity needed to separate analyte spectra from isobaric interferences and background chemical noise. Identifies the elemental compositions of small molecules.



eatures

Enables analysis of sub-femtomole quantities

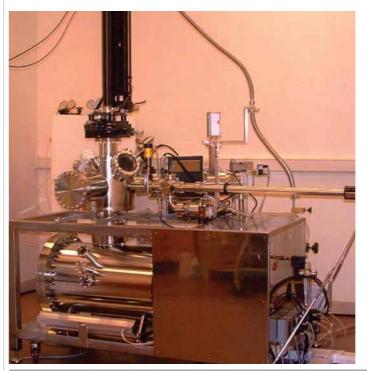
Molecular weight range 200 Da - >500 KDa

In reflection mode with m/z <4kDa high

resolution spectra obtained

of biological and synthetic molecules

High Resolution Electron Energy Loss (HREELS) Spectrometer



Location: Birmingham 1.18

Multi Frequency FT Electron Paramagnetic Resonance (EPR) Spectrometer



Location: Warwick 1.35

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The HREELS technique allows one to resolve finely spaced energy features, necessary for analysing molecular vibrations. The advantage of HREELS over other energy loss spectroscopy is that momentum can be transferred by the electrons to the features being measured, this gives the experimentalist extra information regarding the energy-dispersion relations of surface features and the ability to excite indirect transitions (where spectroscopy with photons as the probe is limited to direct transitions).

Features

- Energy Resolution (Direct Beam) = 0.5meV
- Beam Energy = 1eV to 70eV
- Sample size = up to 2cm square attached to omicron plate
- Temperature range = 77K to 800K (potentially from 4K with He)
- Energy range = 0 to 2eV window, with 40eV movement range
- Pressure = 10E-10torr (UHV), Prep = Ar Ion sputtering, E-beam annealing, LEED analysis.
- spaceonig, 2 seam anneaning, 222s analy.

A large number of materials have unpaired electrons. These include free radicals, many transition metal ions, and defects in materials. Free electrons are often short-lived, but still play crucial roles in many processes such as photosynthesis, oxidation, catalysis, and polymerisation reactions. Hence EPR applications span a wide range of areas from quality control to molecular research in fields such as material research, structural biology, and quantum physics.

For example EPR is able to provide information on long-range interactions (1 to 8nm) between paramagnetic centres and extract conformational information which are difficult to obtain by other technologies (such as NMR, X-ray crystallography).

Features

This is a highly versatile multi-frequency (9.5 and 34 GHz) Fourier Transform Electron Paramagnetic Resonance (EPR) spectrometer equipped for all FT-EPR and Electron Spin Echo techniques including ESEEM and 2D-HYSCORE to measure spin density distribution and distances through the hyperfine interaction between electron and nuclear spins, SECSY and EXSY to measure correlations and exchange rates, Pulse-ELDOR and DEER to measure long range distances by electron-electron spin dipolar coupling, pulse-ENDOR to measure hyperfine interactions and nuclear spin relaxation, and laser triggered experiments to investigate chemical reactions and triplet states.

Solid State NMR suite



Millburn House has thirteen superconducting magnets for performing NMR, ranging from 850 MHz (proton Larmor frequency) to 100 MHz for solid-state NMR, 700 and 600 MHz for solutionstate NMR and a three magnet solid-state DNP system.

Over sixty probes enable NMR to be performed over a wide temperature range from 90 K to 1000 K, with air or nitrogen gas, and MAS rotors ranging from 1.3 mm (65 kHz spinning) - 1.8 mm (45 kHz spinning) - 2.5 mm (35 kHz spinning) - 3.2 mm - 4 mm - 7 mm - 9 mm - 14 mm (4 kHz spinning). There are also two Double-Rotation (DOR) probes.

pectrometers Rotors

- 600 MHz Bruker Avance II+
- 500 MHz Bruker Avance III 400 MHz Bruker Avance 400
- 300 MHz Varian InfinityPlus
- 300 MHz Field-Sweep
- Chemagnetics Infinity
- 200 MHz Chemagnetics Infinity
- 100 MHz Chemagnetics Infinity DNP: 143 MHz Super Widebore
- Chemagnetics Infinity
- DNP: 600 MHz Sweepable Varian
- Doty 7 mm Samoson 1.8 mm

Doty 4 mm

Samoson DOR

Bruker 2.5 mm

Bruker 3.2 mm

Bruker 4 mm

Bruker 7 mm

Chemagnetics/Varian 3.2 mm

Chemagnetics/Varian 4 mm

Chemagnetics/Varian 6 mm

Chemagnetics/Varian 9.5 mm

Chemagnetics/Varian 14 mm

Location: Warwick 1.36

850MHz Solid State NMR

Bruker 4 channel HFXY with 11 MAS and static probes



Location: Warwick 1.38

The 850 MHz system is a world-leading UK facility delivering advances in materials science, chemistry, biology, earth science and physics, jointly funded through EPSRC, BBSRC and the Advanced Materials (1 and 2) projects.

Solid-state NMR provides information about the structure of solids and is especially suitable for studying disordered materials which lack long range order.

Solid-state NMR uses nuclear spin as a "local probe" to investigate short range arrangements in materials in contrast to, for example, X-ray diffraction. It can be also used to study the structure and conformations of single molecules, the interaction between various molecules and nuclei, local dynamics, kinetics and dynamics at molecular levels. The systems of interest can range from small organic or inorganic molecules, to mid-sized clusters or peptides and up to large structures such as proteins or polymers.

-eatures

- UltraShield cryomagnet: bore size 89mm and persistent magnetic field of 20 Tesla
- Avance III ultrafast console (4 channels)
- Temperature control down to 150 K
- A range of 1.3, 2.5, 3.2, 4 and 7 mm MAS probes

X-ray and UV Photoelectron Spectroscopy (XPS & UPS)

Omicron Gmbh & VG Scienta



Location: Warwick 1.22

Lambda 1050 Spectrophotometer for Optical Absorption



Architectural and Specialty Glass: Energy conservation is more important now than ever before. Analysis of coated glass provides important information on thermal efficiency and other key design considerations.

Solar Energy Research: The LAMBDA 1050's capability in the NIR region allows full characterisation of not only the active solar cell materials but also the reflective protective covering.

Location: W

Steady State and Time Correlated Single Photon Counting (TCSPC)

Fluorescence Spectrometer Edinburgh Instruments



Modular instrument for measuring fluorescence and phosphorescence decays on molecular nanomaterials

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This instrument combines several electron spectroscopy techniques that can be applied to investigate the chemical composition and electronic structure of surfaces and interfaces. The instrument includes a monochromated twin-anode X-ray source (Al & Mg K) and a multi-channel channel concentric hemispherical analyser for high resolution X-ray photoelectron spectroscopy (XPS - supplied by Omicron GmbH).

In addition there is a high intensity un-monochromated X-ray source, a low energy electron flood gun (for non-conducting samples), low energy electron diffraction (LEED) for surface crystallography, an ion sputter gun for elemental depth profiling, and a preparation chamber for deposition and in-situ sample pre-treatment. Samples are transferred through the system on sample plates and can be moved to an adjoining chamber with high resolution UV photoelectron spectroscopy (UPS - supplied by VG-Scienta) consisting of a monochromated high intensity helium discharge lamp and a Scienta R4000 high resolution electron analyser. This combination allows valance band electronic structure of materials and deposited overlayers to be investigated, with samples mounted on a 5-axis manipulator with a temperature range of 30 -1000K

eatures

High resolution XPS for surface and interface chemical analysis Facilities for electron spectroscopy of non-conducting samples Electronic structure determination, valance band and Fermi surface mapping

- Elemental depth profiling
- Vacuum suitcase transfer from other growth/vacuum chambers under UHV conditions.

eatures

The LAMBDA 1050 is a high sensitivity and high esolution spectrophotometer for a wide range of demanding applications, such as high absorbing glas optical coatings or thin film filters over the waveleng range 190 - 3300nm. It also features two large ampling compartments and polarizing optics.

It is equipped with an Oxford Instruments Optista cryostat enabling measurements in the range 3.7 to 300K

- Time range 100ps 10s
- Xe flashlamp, pulsed diode laser and LED
- Detection in visible and near IR

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300 and 400 MHz Solution NMR Spectrometers Bruker BioSpin Avance III 300 & 400 300 and 400 MHz NMR Spectrometers refurbished and equipped with automation and new Avance III controllers for routine solution NMR analysis. High performance digital NMR for characterisation of molecular materials and nanoparticles.	 Features 1H, 13C, 19F, 31P as well as more demanding multi-pulse experiments Temperature range -95°C to +110°C Capacity to study traditional inorganic nuclei.
Near IR Spectrometer Varian Cary 5000 Near IR Spectrometer with Harrick Praying Mantis Diffuse Reflection Accessory	Features
value cary 5000 recar in Speciforneter war harrier raying Fiditus Diruse Reflection Accessory	Wavelength: 175 – 3300 nm
Near Infra-Red Spectrometer with cryogenic unit for liquid nitrogen temperature measurements Praying mantis	Cryogenic temperatures Solutions, solid samples and thin films.

Location: Birmingham 2E9

Varian 660 IR FTIR Spectrometer with Pike MIRacle diamone	d ATR
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accessory allows reliable diffuse reflectance studies of powders and other rough surface solid samples.

Records vibrational spectra. Capable of providing information on the chemical constitution of samples and the nature of bonds present.

Fe	atures
F	Records infrared spectra
	Optimised for powder samples

air sensitive samples.

Environmental chamber for the measurement of

Location: Bir

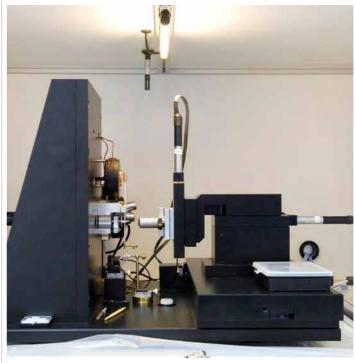


SPECTROSCOPY & SPECTROMETRY // ADVANCED MATERIALS

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ADVANCED MATERIALS // PHYSICAL & MECHANICAL PROPERTIES





Location: Birmingham 2E31

Thermal Analysis Suite Mettler Toledo DSC1-400, DSC1-Star and DSC1-1600



Location: Warwick 2.15, 2.16 & 2.17

25

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Nanoindentation measures mechanical properties and scratch characteristics including fatigue and wear.

Hardness and modulus may be assessed on the nanoscale using diamond-coated indenters.

Features

- Force range 0.1 500mN
- Liquid immersion and humidity control 20 90%RH
- Range of indenter geometries
- Frequency dependent mechanical properties
- Target location identified to $\pm 1\mu m$

Differential Scanning Calorimetry (DSC) is the quantitative measurement of phase transitions used to determine transition temperatures and phase composition of materials e.g. glass transition in polymers, glass/crystal fractions, purity determination in pharmaceuticals.

Thermogravimetric Analysis (TGA) can be used to determine the thermodynamics and kinetics of processes involving weight loss such as corrosion and oxidation.

The technique is used for monitoring of phase changes in high temperature materials such as metals and ceramics.

eatures

High sensitivity DSC: Temperature range -150 to 700°C ± 0.1°C 0.04 µW resolution TGA/DSC: Temperature range: 20 to 1600°C, ± 0.3°C Controlled atmosphere 0.1µg resolution TGA 0.1mW resolution DSC Autosamplers on all three instruments

MUARC (Midlands Ultracold Atom Research Centre)



Study the underlying physics of novel materials or of quantum phenomena underlying material properties by the creation of well defined artificial materials. Examples would be the creation of artificial superconductors, magnetically frustrated systems or conductors with well defined impurities or disorder causing resistivity or localisation.

Provide a suitable laboratory environment to enable cold atom experiments aiming at the creation of artificial materials. The facility will enable the creation and study of artificial 2D materials with many degrees of freedom in parameters, e.g. tunnelling, interaction, lattice geometry.

eatures

Location: Birmingham 1.20

Netzsch STA 449 F1 Jupiter thermal analyser



The thermal analyser can provide a variety information including:

- Temperature and composition of evolved gases
- Mass change for analysis, eg of oxygen content in materials
- Information on phases changes (DSC) even when no mass change occurs.

Location:

Rheometer

TA Instruments AR G2



Rheological analysis of liquids and soft solids for use in implants and delivery systems.

Assessment of the material properties using cone and plate, concentric cylinder and vane geometries is possible.

Location: Birmingham 2E34

Features

nalysis of evolved gases

Features

The Netzsch analyser allows thermal analysis

of materials up to temperatures of 1400°C in

simultaneously. The equipment is linked to a

nass spectrometer which allows immediate

ontrolled atmospheres. Mass change and

calorimetric effects can be monitored

- Ultra-low nano torque control down to 3nN m in controlled stress and direct strain controlled modes
- Frequency range 10⁶ 100Hz
- Temperature control up to 200°C Measurement of Newtonian and

Calorimeter

TA Instruments TAM III



Calorimetry can be used for ultra-sensitive heat flow measurement. The equipment can monitor chemical stability, physical degradation and polymorphic transformations.

formulation and accelerated corrosion testing.

Location: V

Dynamic Vapour Sorption (DVS) Moisture Adsorption Apparatus

Surface Measurement Systems DVSA-STD



The sorption apparatus characterises the behaviour of materials in different humidity and temperature environments.

Vapour sorption isotherms can be measured and compound stability evaluated. Additionally, surface adsorption effects can be examined.

Dissolution Apparatus Varian 705-DS



Monitors the degradation of resorbable biomaterials in addition to release from pharmaceutical materials and devices. Applications include formulations, materials, soluble dosage forms and release in vivo.

Location:

Helium Pycnometer Micro-meritics Accupyc II 1340



wide variety of powders, solids, and slurries as well as bulk objects and porous scaffolds. Uses gas displacement to measure volume.

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27

26

- Example applications include polymer and pharmaceutical development, cement

Features

- Up to four independent calorimeters can be used simultaneously
- 2 x microcalorimeters, 1 x multicalorimeter 1 x solution calorimeter
- Isothermal, step-isothermal or temperature scanning modes
- 15 150°C temperature range
- Isothermal and slow scanning (2°C h¹)
- Temperature stability < 0.01mK / 24h.

Features

- Gravimetric measurements using 0.05µg resolution microbalance
- Organic solute and water reservoirs
- Temperature range 5 to 60°C
- Analysis of solid and powder samples.

Features

- 8-vessel / 8-spindle configuration
- Standard 1L vessels
- US Pharmacopeia (USP) compliance.

- High-speed, high-precision volume measurements and density calculations on a
- Measures the absolute density of solids and slurries with volumes 0.01 to 1.0cm³.

Environmental Mechanical Analyser

Zwick/Roell Z030

Location:

Instron MicroTest 5848

Testing system for compressive and tensile strength of materials.

Example applications include tensile testing of polymers and compressive testing of biocements. Powder compaction studies may also be undertaken.

Enables measurement of mechanical properties, such as tensile and compressive

Fatigue studies may be conducted over expended time periods (weeks).

strengths, as a function of humidity and temperature.

Quantum Design Physical Properties Measurement System (PPMS)

Features

Force range 10 mN to 30 kN

physiological conditions

Liquid immersion facilities to work under

Compressive, tensile and flexural testing.

Tribometry Suite

Tribometer and Nanotribometer

Tribological measurements of friction, lubrication and wear. Nanotribometry may be carried out under controlled humidity and temperature

Location: Birmingham 2E26 & 2E27

Micro-Manipulation System

Custom-built

29

Mechanical characterisation of single micro-particles, single cells, soft solids, MEMS devices, particle-particle interactions and particle-surface interactions.

Location: Birmingham 2E30

Dental Wear Simulators

Proto-Tech Fatigue Cycler, Thermal Cycler and Shrinkage Stress Analyser

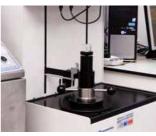
A: Thermal Cycler - reproduces the temperature cycling which occurs in the mouth to evaluate dental materials.

B: Polymerisation Stress Tester - measures stress and shrinkage in polymerisation of dental composites.

Location: Birmingham 2E37

Micropore Analyser

Micromeritics ASAP2000 and Autopore IV



Determines the pore size distribution and pore volume of materials, including dental and medical materials, porous scaffolds and catalysts. Example materials include: catalysts and bio-scaffolds and gas storage materials such as carbons, zeolites and metal organic frameworks.

Chemisorption can be used to investigate active metal dispersions or surface acidity of catalysts. Materials with low surface areas such as powdered metals, glass fibers, and natural organic materials can also be analysed.

Location: Warwick 2.24 & 2E23

wide range of magnetic, thermal and electrical measurements.

The Quantum Design PPMS is an open architecture, variable temperature-field system, designed to perform a variety of automated measurements. It offers a

Features

Features

Force range 10 mN to 2 kN

Humidity range 10 - 80%RH

Temperature up- to 40°C.

Electromechanical position control ~ 5µm

Custom waveforms and strain patterns

Heat capacity: T range, 0.4K - 400K in magnetic fields of up to 9T. Sample mass 5-500 mg with a resolution of 10nJ/K @ 2.0K

Transport Measurements: AC Resistivity, Hall Effect, I-V Curve Tracing, and Critical Current surements, 1 nV sensitivity, n Ω resolution at 2 A. drive amplitude 10µA to 2 A. Thermal conductivit dynamic range 0.1 to 250 W/mK, Seebeck coefficier range 1µV/K to 1V/K. For all the transport neasurements T range 1.8K - 400K in magnetic ields of up to 9T.

Location: Warwick 1.25

MPMS SQUID magnetometer



Magnetic Property Measurement System (MPMS) magnetometer utilises Superconducting Quantum Interference Device (SQUID) technology. The MPMS provides solutions for a unique class of sensitive magnetic measurements in key areas such as high-temperature superconductivity, biochemistry, and magnetic recording media.

Features

lagnetisation Measurements: T range, 0.5K - 800K in magnetic fields of up to 7 T. Maximum sample size ~9 mm diameter by ~20mm long. DC magnetisation, sensitivity 1 x 10-8 emu @ 0 25T

AC susceptibility measurements: 0.1Hz to 1KHz, ensitivity 2 x 10-8 emu at 0T.

Location: B

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Features

- Reciprocating motion and rotating motion.
- Tribometer loads > 1N and Nanotribometer load 1mN - 1N
- Variable environmental conditions.

Features

Measures:

- Compression behaviou
- Stress relaxation behaviou
- Frequency-dependent behaviour
- Variable environmental conditions can
- be employed

Features

- Thermal cycling: 0 80°C
- Fatigue testing:
- Loading up to 400 N
- Up to 4 parallel samples.

- Measures surface areas from 0.001 to 3000m² g¹
- Pore diameters from 0.003 to 360µm
- Resolution > 0.1µL pore size.

ADVANCED MATERIALS // DEPOSITION & GROWTH

applications, with many of them being explored at the moment in Source type: magnetron sputtering the scientific community.

From an industrial perspective, one application is that of catalysis. The properties of small particles (including chemical reactivity) are very different to their bulk counterparts. Such particles could lead to a catalyst (either for the automotive industry or for bulk chemical production) that is produced from much less material in total.

Small particles of very well defined sizes have many potential

Size Selected Cluster Beam

Location: Birmingham 1.10

Pulsed Laser Deposition (PLD)



Location: Warwick 1.21

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eatures

- Target: Material: Most metals and selected semiconductors; Size: 2 inch OD, 6mm thickness (direct cooling) or 4 mm thickness (indirect cooling)
- Beam potential: -1.0kV to +1.0kV
- Mass range: 30 amu to > 20,000,000 amu
- Mass resolution: up to 130 (m/ Δ m)
- Transmission: up to 44%
- Substrate voltage: -1.5kV to +1.5kV
- Beam current : up to 3nA.

This instrument consists of an ultra-high vacuum (UHV) pulsed laser deposition (PLD) system with a series of in-situ surface structural and chemical probes.

The PLD system (supplied by TSST B.V. Holland) allows target materials placed in the chamber to be ablated using a pulsed ultra-violet laser for the growth of thin films of materials - some only a few atoms thick - in a controlled manner. This is achieved by in-situ monitoring of the growth process using reflected high energy electron diffraction (RHEED) to ensure high crystalline perfection in a range of different materials. This PLD system allows different combinations of materials and interfaces to be fabricated from complex oxides to semiconductor materials. The use of UHV and high purity materials ensures that stoichiometric thin films of the highest structural quality can be grown. The system incorporates a number of in-situ surface diagnostic techniques such as X-ray photoelectron spectroscopy (XPS) for determining the surface composition, and scanning probe microscopy, (both STM and AFM - supplied by Omicron GmbH) for topographic and atomic resolution studies of surface and interface structure in the epitaxially grown materials.

-eatures

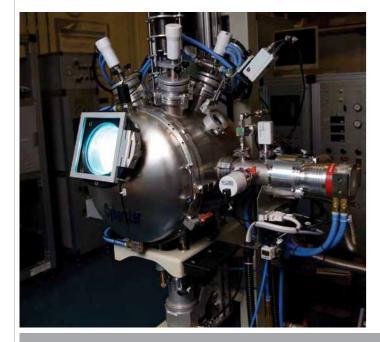
Controlled growth of high quality epitaxial thin films of complex oxides Layer by layer, controlled deposition of the thin films of various materials Deposition and growth of interfaces, multilayer and superlattice structures Optimisation of the growth conditions by in-situ diagnosis of the as grown thin films by RHEED and XPS

Surface structure analysis in-situ using combined STM and AFM.

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Single Crystal Growth Machine

(Cyberstar)



This equipment will be used to melt binary and ternary intermetallic compounds in polycrystalline form. Rods of these compounds can also be made using this method in preparation for crystal growth by the floating zone technique.

Features

- This system will be used as a crystal growth system using 4 arcs (tetra arc) to melt materials on a copper hearth
- This system can be used to produce crystals of intermetallic materials alloys and compounds.
- Includes a radio frequency power generator, capable of delivering 40kW has been acquired to be used in conjunction with an existing cold boat system.

Location:	Warwick	1.23	&	1.24
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Organic Thin Film Deposition and Solar Simulator System mBraun 200B Glovebox with Solar Simulator

The system may be used for the formation of thin organic films via evaporation and deposition with controlled rate and thickness. Solar simulation allows the testing of the response of films to 1sun simulated solar irradiance.

Glovebox with two anti-chambers and evaporator Solar Simulator with Xe Arc lamp (550W) Quartz Crystal Microbalance for measu of film format

Features

Metal Evaporator Features Edwards E306 Coater Deposition is monitored by quartz crystal microbalance Deposition rates 0.01 or 0.001nm s¹ Location: Birmingham 2E13 Photolithography Clean Room Suite Features Moorfields electron beam evaporator, Recently upgraded Moorfields MiniBox thermal evaporator and sputtering system and Suss Microtec MJB4 Mask Aligner Purpose built clean room facility housing a variety of equipment to facilitate photolithographic processing of device structures.

Location: Warwick 1.27

Location: Warwick 2.4

Moorfields electron beam evaporator - controlled thin film deposition of metals such as Pt, Ni etc Thermal evaporator and sputtering system - controlled thin film deposition of both metals and insulators including Pt, Au, Ti, Cr, Al, SiOx etc

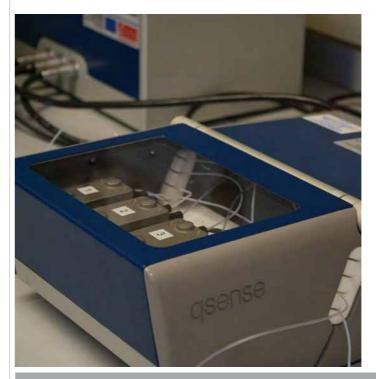
Suss Microtec MJB4 Mask Aligner - high resolution printing down to 0.5µm.

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DEPOSITION & GROWTH // ADVANCED MATERIALS

Quartz Crystal Microbalance (QCM) Qsense QCM-D E1 & E4 System



Location: Warwick 2.3

Ellipsometer Nanofilm EP3-SE



Location: Warwick 2.10

ADVANCED MATERIALS // SURFACE ANALYSIS

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The Quartz Crystal Microbalance provides mass and structural information on molecular layers that form on the surface of a sensor. Molecular adsorption and interactions can be monitored in real time under a variety of conditions. Sensors can be chemically modified to produce a range of surfaces for study.

QCM can be used in a range of applications, for example to investigate the hydration of polymer films, monitor protein interactions with a variety of surfaces, or study the effectiveness of surfactants in removing lipid films.

Features

- Multiple sensor unit for up to four flow cells in series or parallel configuration
- Electrochemical cell
- Temperature range from 15 45°C
- Dissipation monitoring gives information on rigidity of film
- Sensitivity of the order of 2ng cm⁻²
- Resolution of 200 data points per second.

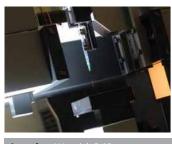
Ellipsometry may be used for the determination of film thickness, morphology, microtribology, electric and optic properties of multilayer metal/metaloxides; self assembled molecules and thin film polymeric materials; next generation energy-efficient glazings. Surface plasmon resonance package is available for molecular surface interaction investigations.

- Spectroscopic ellipsometer with 46 wavelengths between 365nm to 1000nm
- Wavelength and angle of incidence scanning
- Mapping function
- Lateral resolution 1µm
- Surface plasmon resonance (SPR) cell.

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Drop Shape Analyser

Kruss DSA-100



Static and dynamic contact angles of liquids on surfaces, interfacial and surface tensions of liquids and surface energies of solids can be measured. Applications include wetting properties of plastics, glasses or metals, effectiveness of surfactant solutions and investigating adhesion properties.

Features

- Contact angle (sessile drop)
- Surface tension (pendant drop) Tilting table
- EDM/ODM module (Expanding Drop Method
- Oscillating Drop Method)
- Humidity chamber High speed camera available

Features

Vertical range up to 50mm

Dissimilar materials analysis

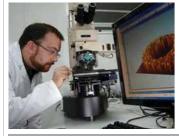
100mm x 100mm sample positioning stage

Phase mode for nanoscale resolution Surface roughness may be quantified

Location: Warwick 2.19

Interferometer

KLA Tencor MicroXAM2



Interferometry measures surface topography and wear volume through three-dimensional surface profiling.

Equipment may be used to measure coating film thickness up to 60µm.

Location:

Ti:Sapphire Femtosecond laser system. Optical measurements and characterisation



The system may be used for the formation of thin organic films via evaporation and deposition with controlled rate and thickness. Measurements of materials reflectivity and absorption properties, determination of excitation decay dynamics, determination of real and imaginary parts of dielectric constants by means of static and time resolved ellipsometry, design and implementation of advanced optical set-ups, optical measurements automation and optimisation.

Location:

Features

- Micra 'seed' laser: 400mW pulses at 80MHz. Lamda = 800nm, Pulse Duration 40fs, Bandwidth 100nm.
- Legend Amplifier: 4W pulses at 1kHz repetition Lambda = 800nm, Pulse Duration 30fs, Bandwidth 40nm.
- OPA for wavelength tuning between 250-20000nm.
- CEP for < 1mrad stability in phase of pulses.

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SURFACE ANALYSIS // ADVANCED MATERIALS

FEI Quanta 3D Focussed Ion Beam - Scanning Electron Microscope (FIB-SEM)



Location: Birmingham 1.19

Oxford Instruments "PlasmaPro NGP80" Inductively Coupled **Plasma Etching Machine**

The Oxford Instruments NGP 80+ is a versatile plasma etching tool, used for transferring patterns from a photoresist or other mask into materials such as silicon, silicon dioxide, glass, ITO and others.

The machine can be used for isotropic or anistropic etching of substrates, ethcing of high aspect ratio structures uses the Bosch process, and is highly controllable allowing the successful etching of features small than 30nm.

Location: Birmingham 1.14

Disco "Automatic Dicing Saw DAD321" Wafer Dicer

The Disco 321 is a high accuracy dicing machine for cutting hard or brittle materials such as semiconductor wafers and glasses.

Blades for silicon and silicon dioxide wafer cutting are routinely stocked and blades for a wide range of other materials including ceramics, composites, oxides, glasses and ferrites are available from the supplier. The dicer can be used to accurately cut materials into sub millimetre or several cm sized pieces, with micron accuracy. Cutting depth is blade and time limited, but can be several millimetres.

Location: Birmingham 1.15

ADVANCED MATERIALS // MICROFABRICATION

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There are two important applications:

- 1. 3D SEM. Produces 3D images from 100x100x100µm. Images can be secondary electrons or X-rays (chemical images)
- 2. TEM (transmission) specimen production from any selection or combination of materials (e.g. polymers, ceramic etc).

eatures

The Quanta 3D FEG is a versatile high-resolution, low vacuum SEM/FIB for 2D and 3D material characterisation and analysis. The Quanta 3D FEG's field-emission electron source lelivers clear and sharp electron imaging. Increased electron beam current enhances EDS and EBSP analysis. Featuring three imaging modes - high-vacuum, low-vacuum and ESEMTM. Quanta 3D FEG's high-current FIB enables fast material removal. Automated FIB sectioning recipes enable accurate cross-sectioning

lectron beam resolution

- High-vacuum (0.8nm at 30kV (STEM); 1.2nm at 30kV (SE); 2.5nm at 30kV (BSE); 2.9nm at 1kV (SE))
- Low-vacuum (1.5nm at 30kV (SE); 2.5nm at 30kV (BSE); 2.9nm at 3kV (SE))
- Extended low-vacuum mode (ESEM) (1.5nm at 30kV (SE))
- Ion beam resolution
- 7nm at 30kV at beam coincident point (5nm achievable at optimal working distance)

Electron optics

- High-resolution field emission SEM column mised for high brightness/ high-current optimised * optional
- 60 degree objective lens geometry with through-the-lens differential pumping and heated objective apertures

- Accelerating voltage: 200V 30kV (optional down to 100V)
- Probe current: up to 200nA continuously adjustable
- Magnification 30 x 1280kx in " quad" mode lon optics
- High-current ion column with Ga liquid-metal ion source
- Source lifetime: 1000 hours guaranteed
- Acceleration voltage: 2 30kV
- Probe current: 1pA 65nA in 15 steps
- Beam blanker standard, external control possib
- 15-position aperture strip
- Magnification 40 x 1280kx in " quad" mode at 10k
- Charge neutralisation mode for milling of non-conductive samples

Features

- Reactive Ion Etching of wafers up to 6" in diameter
- Inductively Coupled Plasma Etching of wafers up to 2" in diameter
- Bosch Process Deep Reactive Ion Etching of wafers up to 2" in diameter
- Etchant and Passivant gases including SF₆, CF₄, CHF₃, C4F₈, O₂, Ar, SF₆
- Temperature controlled wafer stage (1 to 90 degrees celsius) with helium clamping.
- Silicon etching rates up to 2.5µm/min
- High resolution etching of sub 30nm photoresist features.

- Dicing and scribing of wafers (eg Silicon) upto 6" in diameter
- Lateral Cutting Position accuracy better than +/-10 micron
- Vertical Cutting Depth accuracy better than +/- 5 microns
- Rotational Wafer Positioning in 0.01 degree step
- Deionised cooling water supply
- Optical microscope for blade/wafer alignment Blades for silicon dicing available. Blades for
- other materials can be ordered.

4() + 41

ADVANCED MATERIALS // CHROMATOGRAPHY

Gel Permeation Chromatography (GPC) Polymer Analysis Suite Varian (Polymer Labs) 4 x 390-LC Systems & PL-GPC 220 Varian (Polymer Labs) PL-PMC-003



Location: Warwick 2.1 & 2.2

High Performance Liquid and Gas Chromatography (HPLC and GC) Systems



Two HPLC and two GC systems for analysis of molecular materials and nanomaterials.

Fast Protein Liquid Chromatography (FPLC) Equipment GE Healthcare 2 x AKTA-Purifier 900/950

FPLC is used for purification and characterisation of proteins and peptides and their conjugates with polymers. Applications include hybrid biosensors and macromolecular devices.

Location: Warwick 2.12

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GPC may be used to measure relative molecular weight and polydispersity of polymeric samples.

Examples of applications include: commercial plastics, polymer-bioconjugates, personal care products, lubricants, agrochemicals, packaging materials etc.

Equipment for monitoring reaction kinetics through continuous sampling with automated acquisition and analysis in real time with concentration monitoring via UV and DRI detection and molecular weight measurements using light scattering.

eatures

- Full range of commercial columns and solvent capability
- DMF, THF, Aqueous & Chloroform etc
- Multi Detector Systems
- Viscometry, Differential Refractive Index (DRI), Light Scattering, UV, Fluorescence, Photodiode Array (PDA)
- High temperature (30-220°C).

eatures

2 x HPLC systems with multiple detectors:

- variable wavelength UV
- photo diode-array (scan through 190nm - 800nm for eluted compounds)
- evaporative light scattering (for use when no chromophore is present)
- fluorescent detection (for use with markers)
- $2 \ \mathrm{x} \ \mathrm{GC}$ systems supporting high speed analysis
- cooling from 450 to 50°C in 6 minutes
- 970kPa and 1200ml/min.

2 x FPLC systems:

- Flow rate up to 20 mL/min
- Monitors analytes by UV, conductivity and pH.

ADVANCED MATERIALS // PARTICLE SIZE & SHAPE

Particle Size and Shape Analyser

QICPIC and HELOS/BF Sympatec



wet samples including suspensions, powders and emulsions.

High speed analysis of particle size distribution is possible. Shape analysis yields aspect ratio and sphericity.

Location:

Dark Field Particle Tracker Nanosight LM10

Particle sizing using Brownian motion tracking for a variety of applications, including ceramics, viruses, colloidal suspensions, polymer nanoparticles, and wear debris in lubricants.

Location: Warwick & Birmingham 2.20 & 2E6

Dynamic Light Scattering Zetapotential Apparatus Malvern Instruments Nano-ZS

Measures size and zeta potential of colloids to give information on stability, polydispersity of nanoparticles, and presence of aggregates (e.g. of proteins). Can be used in analysing size of colloids and nanoparticles, pigments and inks, Protein size, proteomics, melting point, colloid stability, water treatment, isoelectric point determination. Location: Warwick 2.21

High RPM Disc Centrifuge

CPS Instruments AS200 and Analytik DC24000

Measures particle size via sedimentation behaviour. Applications include polymer latexes and emulsions, silica dispersions, micro-encapsulated drugs, pigments, and starch particles.

Location: Warwick & Birmingham 2.22 & 2E39

Powder Particle Sizer

Malvern Instruments 2000 System

Measures particle radius of a variety of wet or dry powders, dispersions or emulsions by laser diffraction.

Location: Warwick 2.23

Zeta Potentiometer and Molecular Weight Characteriser Beckman Coulter Delta Nano C

Instrument for analysing charge and size of nanoparticles.

Location: Birmingham 2E7

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- Equipment for the characterisation of particulate systems including both dry and

eatures

- Particle size 1µm to 6µm
- Aerodispersions, sprays
- High-speed camera: up to 500Hz
- Study of agglomerated fine and cohesive powders: 1µm to 6µm
- Laser diffraction sensor 0.1µm 875µm for wet and dry samples.

Features

- Particles illuminated by 40mW 640nm laser tracked and quantified by software
- Size range typically 10 1000nm
- Sample volume 0.3ml
- Polydisperse and multimodal systems identifiable

Features

- Measures hydrodynamic size and zeta potentia
- Particle size (0.6nm 6µm diameter) over the molecular weight range (1000 - 2x10⁷ Da) Temperature control 0 - 90°C
- 4mW HeNe laser 632.8nm.

Features

- Size range approximately 5nm 50µm depending on density
- Dynamic range (ratio of largest to smallest sizes) ~ 70 with constant centrifuge speed
- Maximum speed 24,000rpm
- High resolution (can separate 2% size differen

Features

- Size range 0.2µm 2000µm
- Sizing on emulsions, suspensions and dry powders
- Dual wavelength; HeNe (red) and solid state (blue) lasers.

- Particle size: 0.6nm 7µm
- Zetapotential: -100mV +100mV
- Concentration 0.001 40%
- pH 1 13
- Temperature: 10 90°C.

Surface Plasmon Resonance (SPR) Equipment

Reichert SR7000DC



high quality, real time kinetic data requiring no tags or labelling of compounds or proteins. Example application include the study of proteins, antibodies, peptides, DNA or lipids as well as investigating drug binding or antibody-antigen interactions.

Gel Electrophoresis Kit

Genetic Research Instrumentation (GRI)Alpha-Imager HP System

High resolution fluorescent and visible imaging for culture plate & microplate based arrays.

Location: Birmingham 2E11

Bioanalyser

Agilent 2100

A microfluidics-based platform for sizing, quantification and quality control of DNA, RNA, proteins and cells. Example applications: characterisation of protein sensors – lab on a chip technology

Location: Warwick 2.13

Microwave Reaction Station

CEM Discoverer S-Class

The reaction station allows up to 48 microwave reactions to take place simultaneously for chemical syntheses, including polymers and peptides.

Location: Birmingham 2E17

Laser Vibrometer

Polytec OFV-5000

Measures vibration amplitude, frequency and spatial location to give full vibration mapping of an object under test. The integral video camera can be used to monitor the area and provide a captured image for superimposition of the vibration data. Used for the evaluation of the design of dental instrumentation such as ultrasonic scalers and dental drills.

Location: Birmingham 2E35

ADVANCED MATERIALS // BIOANALYSIS

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Surface Plasmon Resonance (SPR) measures biomolecular interactions providing

Features

- Real-time simultaneous dual-channel SPR
- Temperature range: 10 90°C
- Sample loop: 10µL 2mL
- Flow rate: 1µL/hr 10mL/min.

Features Motorised lens Incident white light for focussing and positioning Dual wavelength transilluminator White light table Five-position filter wheel. Features 10-12 samples in parallel 30-40 min analysis time. Features 10, 35, 80ml capacity at 21 bar, or 125ml at atmospheric pressure Manual peptide solid phase synthesis accessory Gas (H₂,CO) addition accessory. Features

- Frequency range from near DC to 24MHz
- Velocities to ± 10m/s
- Displacements from the sub-nanometer to meter range.